

<b>Notice of References Cited</b>	Application/Control No. 10/620,688	Applicant(s)/Patent Under Reexamination HANAMOTO, TAKASHI	
	Examiner Beniyam Menberu	Art Unit 2625	Page 1 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0228524 A1	11-2004	Okutsu et al.	382/162
*	B	US-2003/0067626 A1	04-2003	Ohmori et al.	358/1.15
*	C	US-6,980,223	12-2005	Jang et al.	345/604
*	D	US-2002/0093698 A1	07-2002	Kagawa, Tetsuya	358/518
*	E	US-2002/0080380 A1	06-2002	Sugiura et al.	358/1.13
*	F	US-6,563,945	05-2003	Holm, Jack M.	382/162
*	G	US-7,057,772	06-2006	Bannai, Nobuyuki	358/3.01
*	H	US-6,947,589	09-2005	Newman et al.	382/162
*	I	US-2003/0035127 A1	02-2003	Nakami, Yoshihiro	358/1.9
*	J	US-2003/0034986 A1	02-2003	Fukasawa, Kenji	345/591
*	K	US-5,874,988	02-1999	Gu, Xueming Henry	348/97
*	L	US-6,198,553	03-2001	Yamamoto et al.	358/520
*	M	US-2002/0122194 A	09-2002	Kuwata et al.	358/1.9

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 07-178966	07-1995	Japan	Satake, Yoshifumi	B41J 2/525
	O	JP 2001-057640	02-2001	Japan	Shinoda, Hiroshi	H04N 1/48
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/620,688	Applicant(s)/Patent Under Reexamination HANAMOTO, TAKASHI	
	Examiner Beniyam Menberu	Art Unit 2625	Page 2 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,975,437	12-2005	Takemoto, Fumito	358/518
*	B	US-6,629,107	09-2003	Ouchi et al.	707/104.1
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	T	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.